

# MAZC062D

## Silicon planar type

For surge absorption circuit

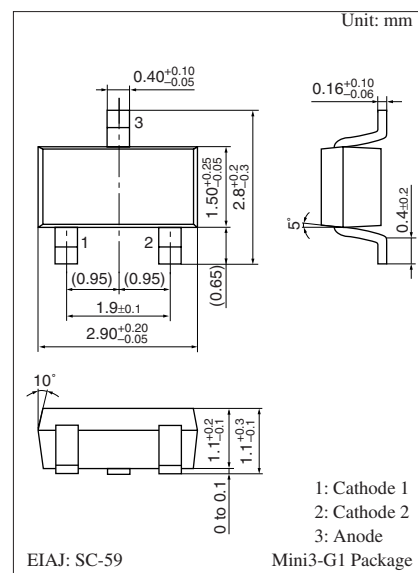
### ■ Features

- Low junction capacity zener diode
- Two elements anode-common type

### ■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

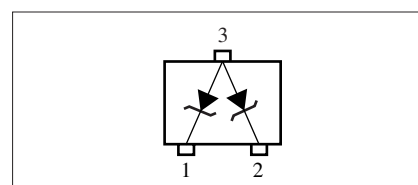
Parameter	Symbol	Rating	Unit
Repetitive peak forward current	$I_{\text{FRM}}$	200	mA
Power dissipation*	$P_D$	200	mW
Junction temperature	$T_j$	150	$^\circ\text{C}$
Storage temperature	$T_{\text{stg}}$	-55 to +150	$^\circ\text{C}$

Note) \*:  $P_{\text{tot}} = 200 \text{ mW}$  achieved with a printed circuit board.



Marking Symbol: 6.2C

Internal Connection



### ■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Forward voltage	$V_F$	$I_F = 10 \text{ mA}$		0.9	1.0	V
Zener voltage*	$V_Z$	$I_Z = 5 \text{ mA}$	5.9		6.5	V
Zener rise operating resistance	$R_{ZK}$	$I_Z = 0.5 \text{ mA}$			100	$\Omega$
Zener operating resistance	$R_Z$	$I_Z = 5 \text{ mA}$		30	$\Omega$	
Reverse current	$I_R$	$V_R = 5.5 \text{ V}$			3	$\mu\text{A}$
Terminal capacitance	$C_t$	$V_R = 0 \text{ V}, f = 1 \text{ MHz}$		8		pF

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

2. Absolute frequency of input and output is 5 MHz

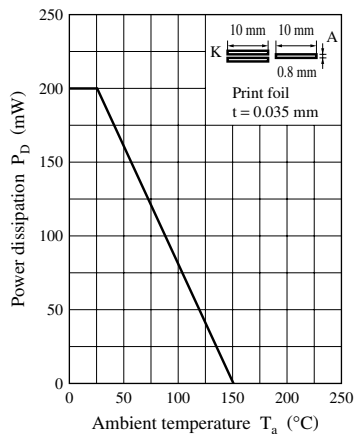
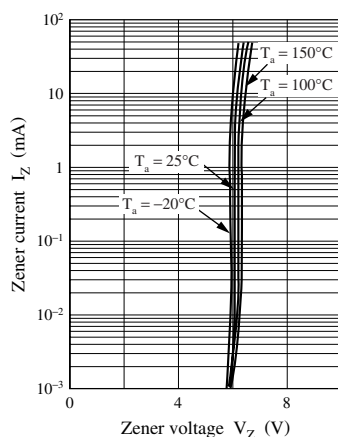
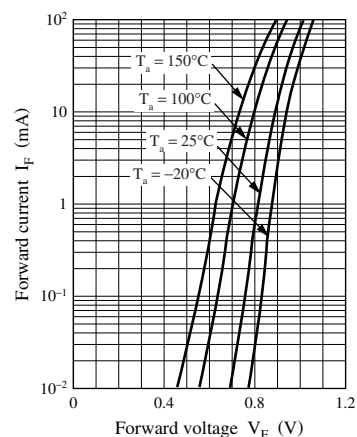
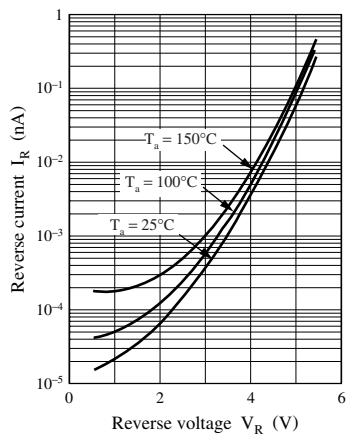
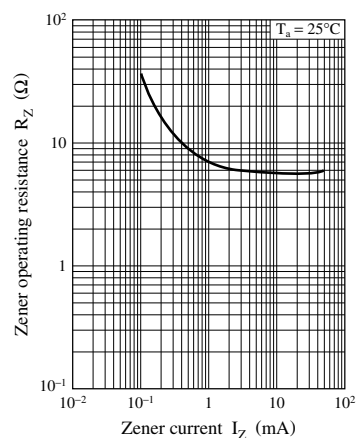
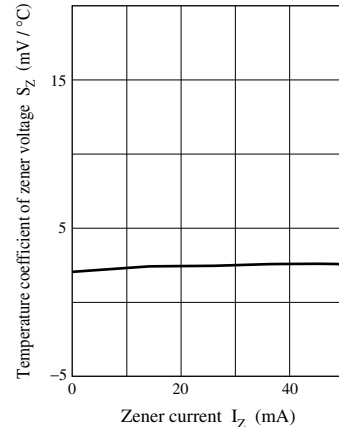
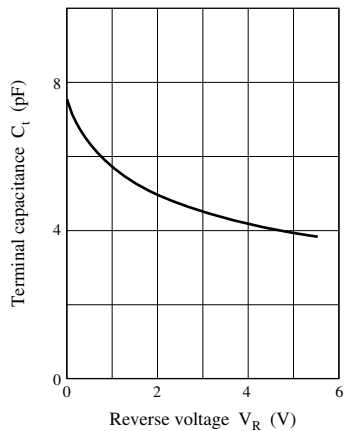
3. Electrostatic breakdown voltage:  $\pm 15 \text{ kV}$

Test method: IEC-801 ( $C = 150 \text{ pF}$ ,  $R = 330 \Omega$ , Contact discharge: 10 times)

Test unit: ESS-200AX

4. \*: The  $V_Z$  value is for the temperature of  $25^\circ\text{C}$ . In other cases, carry out the temperature compensation.

Guaranteed at 20 ms after power application.

$P_D - T_a$  $I_Z - V_Z$  $I_F - V_F$  $I_R - V_R$  $R_Z - I_Z$  $S_Z - I_Z$  $C_t - V_R$ 

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